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U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 12203-007001

Application No. 10/723,442

Information Disclosure Statement by Applicant (Use several sheets if necessary) Applicant Ernie H. Lin et al.

Filing Date

Group Art Unit 2682

(37 CFR §1.98(b))

November 26, 2003

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Application No. 10/723,442

Information Disclosure Statement by Applicant (Use several sheets if necessary) Applicant
Ernie Lin et al.

Filing Date

Group Art Unit 2682

(37,65 R §1.98(b))

November 26, 2003

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Information Disclosure Statement by Applicant	Applicant Ernie Lin et al.			
(Use several sheets if necessary) (37 CFR §1.98(b))	Filing Date November 26, 2003	Group Art Unit 2682		

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